

MOS FIELD EFFECT TRANSISTOR μ PA1952

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1952 is a switching device, which can be driven directly by a 1.8 V power source.

The device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 1.8 V drive available
- Low on-state resistance

RDS(on)1 = 135 m Ω MAX. (VGS = -4.5V, ID = -1.0 A)

 $R_{DS(on)2} = 183 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -2.5 \text{ V, Ip} = -1.0 \text{ A)}$

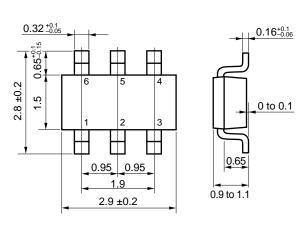
 $R_{DS(on)3} = 284 \text{ m}\Omega$ MAX. (Vgs = -1.8 V, ID = -0.5 A)

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|-----------------------------|
| μ PA1952TE | SC-95 (Mini Mold Thin Type) |

Marking: TP

PACKAGE DRAWING (Unit: mm)

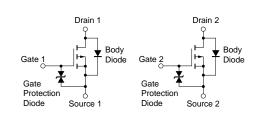


- 6: Drain 1
- 4: Drain 2
- 1: Gate 1 5: Source 1
- 3: Gate 2 2: Source 2

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | Voss | -20 | V |
|---|-----------------------|-------------|----|
| Gate to Source Voltage (Vbs = 0 V) | Vgss | ∓8.0 | V |
| Drain Current (DC) | I _{D(DC)} | ∓2.0 | Α |
| Drain Current (pulse) Note1 | I _{D(pulse)} | ∓8.0 | Α |
| Total Power Dissipation (2 units) Note2 | P _{T1} | 1.15 | W |
| Total Power Dissipation (1 unit) Note2 | P _{T2} | 0.57 | W |
| Channel Temperature | T_ch | 150 | °C |
| Storage Temperature | T _{stg} | -55 to +150 | °C |

EQUIVALENT CIRCUITS



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board of 5000 mm² x 1.1 mm, $t \le 5$ sec.

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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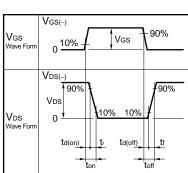


ELECTRICAL CHARACTERISTICS (TA = 25°C)

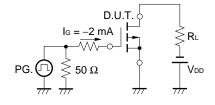
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|-------|-------|------|------|
| Zero Gate Voltage Drain Current | IDSS | V _{DS} = -20 V, V _{GS} = 0 V | | | -10 | μΑ |
| Gate Leakage Current | Igss | $V_{GS} = \mp 8.0 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ∓10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | $V_{DS} = -10 \text{ V}, I_{D} = -1.0 \text{ mA}$ | -0.45 | -0.75 | -1.5 | V |
| Forward Transfer Admittance | yfs | $V_{DS} = -10 \text{ V}, I_{D} = -1.0 \text{ A}$ | 1.0 | 4.1 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | $V_{GS} = -4.5 \text{ V}, I_{D} = -1.0 \text{ A}$ | | 108 | 135 | mΩ |
| | RDS(on)2 | $V_{GS} = -2.5 \text{ V}, I_{D} = -1.0 \text{ A}$ | | 137 | 183 | mΩ |
| | RDS(on)3 | $V_{GS} = -1.8 \text{ V}, I_{D} = -0.5 \text{ A}$ | | 170 | 284 | mΩ |
| Input Capacitance | Ciss | V _{DS} = -10 V | | 272 | | pF |
| Output Capacitance | Coss | Vgs = 0 V | | 60 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1.0 MHz | | 30 | | pF |
| Turn-on Delay Time | t d(on) | $V_{DD} = -10 \text{ V}, \text{ ID} = -1.0 \text{ A}$ | | 29 | | ns |
| Rise Time | tr | Vgs = -4.0 V | | 120 | | ns |
| Turn-off Delay Time | t d(off) | R _G = 10 Ω | | 145 | | ns |
| Fall Time | t f | | | 148 | | ns |
| Total Gate Charge | Q _G | V _{DD} = -16 V | | 2.3 | | nC |
| Gate to Source Charge | Qgs | V _G S = -4.0 V | | 0.6 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = -2.0 A | | 0.6 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 2.0 A, V _G S = 0 V | | 0.9 | | V |

TEST CIRCUIT 1 SWITCHING TIME

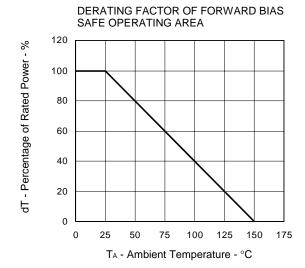
PG. R_{G} $\tau = 1 \mu s$ Duty Cycle $\leq 1\%$



TEST CIRCUIT 2 GATE CHARGE



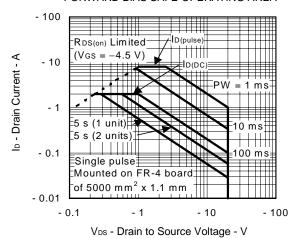
TYPICAL CHARACTERISTICS (TA = 25°C)



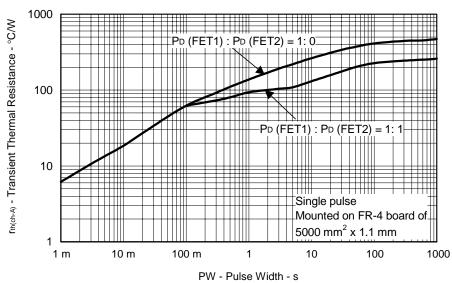
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE 1.2 Mounted on FR-4 board of PT - Total Power Dissipation - W $5000 \text{ mm}^2 \text{ x } 1.1 \text{ mm}, \text{ t} \le 5 \text{ sec}.$ 0.8 2 units 0.6 unit-0.4 0.2 0 0 25 50 75 100 125 150 175

TA - Ambient Temperature - °C

FORWARD BIAS SAFE OPERATING AREA

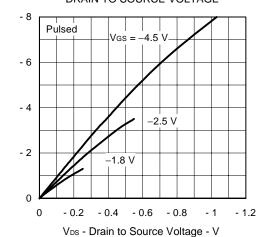


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

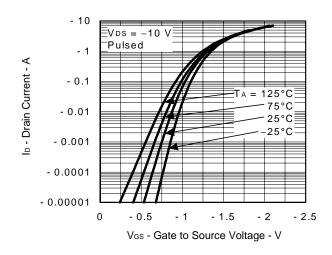


lo - Drain Current - A

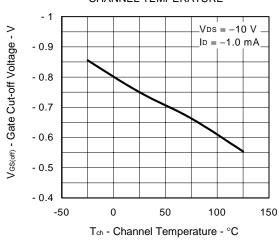
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



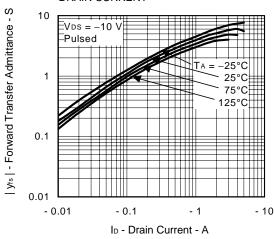
FORWARD TRANSFER CHARACTERISTICS



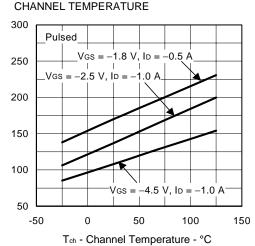
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



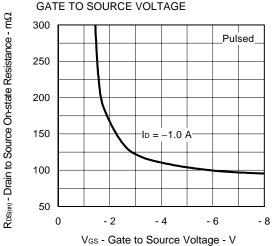
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs.



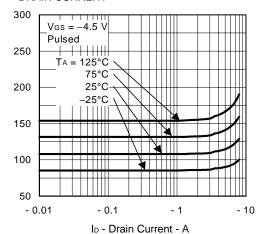
DRAIN TO SOURCE ON-STATE RESISTANCE vs.



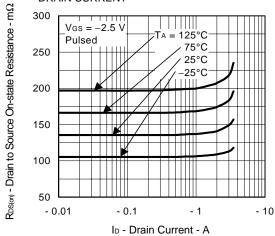
R_{DS(m)} - Drain to Source On-state Resistance - mΩ

RDS(m) - Drain to Source On-state Resistance - m\Omega

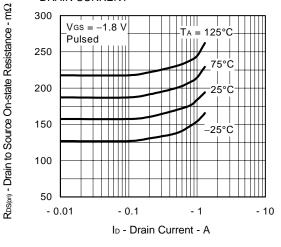
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



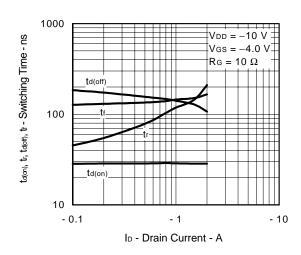
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



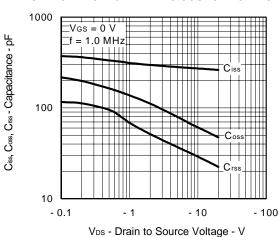
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



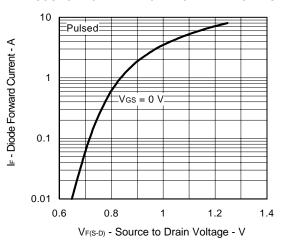
SWITCHING CHARACTERISTICS



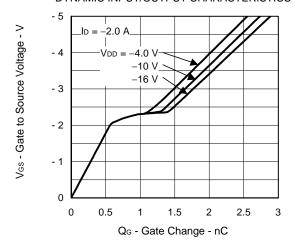
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



NEC μ PA1952

[MEMO]

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